

Search Notes

Application/Control No.

10/074,090

Examiner

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Applicant(s)/Patent under
Reexamination

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Art Unit

2137

SEARCHED

Class	Subclass	Date	Examiner
713	161	4/18/2006	MDN
705	1-3	4/18/2006	MDN
600	544	4/18/2006	MDN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated inventor name search on EAST (US-PAT; US-PG-PUB; EPO; JPO; DERWENT; IBM-TDB)	4/18/2006	MDN